## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | HIRAMATSU ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,146,906 A	09-1992	Agatsuma, Eiji	123/634
	В	US-6,122,971 A	09-2000	Wlodarczyk, Marek T.	73/705
	С	US-6,169,471 B1	01-2001	Sakamaki et al.	336/96
	D	US-6,178,957 B1	01-2001	Widiger et al.	123/634
	E	US-6,215,385 B1	04-2001	Ogden, Jeffrey Dan	336/96
	F	US-6,259,344 B1	07-2001	Heritier-Best et al.	123/634
	G	US-6,276,348 B1	08-2001	Skinner et al.	123/634
	Н	US-6,340,303 B2	01-2002	Hamada et al.	439/127
	ı	US-6,639,498 B2	10-2003	Shimada et al.	123/634
	J	US-6,668,810 B1	12-2003	St. John et al.	439/127
	к	US-6,694,958 B2	02-2004	Hiramatsu et al.	123/634
	L	US-6,724,289 B2	04-2004	Moga et al.	336/90
	М	US-6,880,540 B2	04-2005	Fuma et al.	123/634

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2				,	
	0					
	Ρ					
	ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.